

<b>Notice of References Cited</b>	Application/Control No. 10/547,445		Applicant(s)/Patent Under Reexamination WAGH ET AL.	
	Examiner SHENG HAN		Art Unit 4162	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,645,518	07-1997	Wagh et al.	588/318
*	B	US-5,846,894	12-1998	Singh et al.	501/155
*	C	US-2003/0131759	07-2003	Francis et al.	106/286.1
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	K	US-			
	L	US-			
	M	US-			

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#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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